## Applicant(s)/Patent Under Application/Control No. Reexamination 09/936,611 NAKASHIMA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1746 Jonathan S. Crepeau **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 429/231.95 US-6,168,888 01-2001 lwata et al. Α 429/224 US-5,532,084 07-1996 Wang et al. В ⊌Ş-С US-D US-Ε US-F US-G US-Н 1 US-US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY 04-2000 Japan (abs., translation only) JP 2000-113877 Ν JP 11-111342 04-1999 Japan (abs., translation only) 0 10-1997 (abs., translation only) Japan Р JP 09-283180 (abs., translation only) 01-2000 Japan JP 2000-012015 Q 01-2000 Japan (abs., translation only) JP 2000-012014 R JP 11-343109 12-1999 Japan (abs., translation only) S JP 04-132174 05-1992 (with abstract) Т Japan **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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